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Attorney Docket: BHT/3230-86

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

WU

Application No.

10/781,892

Filed

February 20, 2004

Title

METHOD FOR LIFT OFF GaN PSEUDOMASK EPITAXY LAYER USING WAFER BONDING WAY

Group Art Unit

2811

Examiner

Unassigned

Docket No.

BHT/3230-86

OFFICE OF INITIAL PATENT EXAMINATION

:

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

TRANSMITTAL COVER SHEET

Sir:

Transmitted herewith for filing are the following:

- 1. INFORMATION DISCLOSURE STATEMENT.
- 2. Form PTO-1449 (in duplicate), along with copies of the eight (8) articles cited therein.

The Commissioner is hereby authorized to charge any fees which may be required for the filing of this document to **Deposit Account No. 501874**

Respectfully submitted,

Date: June 9, 2004

By:

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INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 CFR 1.56, and 37 CFR 1.97-1.98, the documents listed on the attached form PTO-1449 are hereby made of record in this patent application. Copies of the listed documents, excluding any U.S. patent/publication references, are enclosed.

As this Information Disclosure Statement is being filed prior to the mailing of the first Official Action in this application, no fee is believed due in order to have the enclosed references considered by the Examiner and made of record in the application.

Early action on the merits of the application is earnestly solicited.

Respectfully submitted,

Date: <u>June 9, 2004</u>

By:

Bruce H. Troxell Reg. No. 26,592

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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)			ATTY DOCKET	rno. 3230-86	Af	PPLICATION NO. 10		
			APPLICANT WU et al.					
`	(Use several sheets if necessary) Date Submitted to PTO: JUNE 9, 2004			FILING DATE February 20, 2004			GROUP 2811	
U.S. PATENT DOCUMENTS								
EXAMINED INITIAL C	DOCUMENT NUMBER	DATE	NA	AME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
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	FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COU	COUNTRY		SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
	OTHER	R DOCUMENT(S) (Includ	ding Author, Title, [Date, Pertinent Pag	ges, Etc.)			
		Y. Honda et al.; "Selective Area Growth Of GaN Microstructure On Patterned (111) and (001) Si Substrates"; Journal of Crystal Growth 230"; pp. 346-350; 2001						
	B. Beaumont e Selective Meta	B. Beaumont et al; "Lateral Overgrowth Of GaN On Patterned GaN/Sapphire Substrate Via Selective Metal Organic Vapour Phase Epitaxy: A Route to Produce Self Supported GaN Substrates"; Journal of Crystal Growth 189/190" pp. 97-102; 1998						
	Jaime A. Freit	Jaime A. Freitas, et al.; "Optical And Structural Properties Of Lateral Epitaxial Overgrown GaN Layers"; <i>Journal of Crystal Growth 189/190</i> ; pp. 92-96; 1998						
		Shuji Nakamura et al.; "Present Status Of InGaN/GaN/AlGaN-based Laser Diodes"; Journal of Crystal Growth 189/190; pp. 820-825; 1998						
	GaN by Metalo	Kazumasa Hiramatsu et al; "Selective Area Growth And Epitaxial Lateral Overgrowth of GaN by Metalorganic Vapor Phase Epitaxy and Hydride Vapor Phase Epitaxy"; Materials Science and Engineering B59; pp. 104-111; 1999						
	Tsvetanka S. 2	Tsvetanka S. Zheleva, et al.; "Lateral Epitaxy and Dislocation Density Reduction in Selectively Grown GaN Structures"; <i>Journal of Crystal Growth</i> 222; pp. 706-718; 2001						
	in Metal Bond	W. S. Wong et al.; "In XGa _{1-x} N Light Emitting Diodes on Si Substrates Fabricated by Pd-In Metal Bonding and Laser Lift-off"; <i>Applied Physics Letters Volume 77; Number 18</i> ;pp. 2822-2824; 2000						
		Mitsuru Funato et al.; "Integration of GaN With Si Using a AuGe-Mediated Wafer Bonding Technique"; <i>Applied Physics Letters Volume 77; Number 24</i> ; pp. 3959-3961; 2000						
EXAMINER			1	DATE CONSIDERED				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.